

Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DEATON ET AL.	
		Examiner Steven B. Theriault	Art Unit 2179	Page 1 of 5

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Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DEATON ET AL.	
		Examiner Steven B. Theriault	Art Unit 2179	Page 2 of 5

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Notice of References Cited		Application/Control No.	Applicant(s)/Patent Under Reexamination DEATON ET AL.	
		Examiner Steven B. Theriault	Art Unit 2179	Page 3 of 5

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		Examiner Steven B. Theriault	Art Unit 2179	Page 4 of 5

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		Examiner Steven B. Theriault	Art Unit 2179	Page 5 of 5

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